

CY74FCT163827

20-Bit Buffer

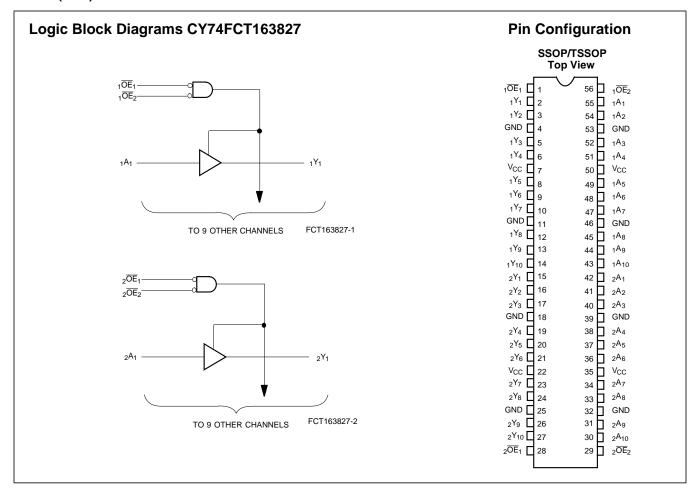
Features

- Low power, pin-compatible replacement for LCX and LPT families
- 5V tolerant inputs and outputs
- 24 mA & 6 mA balanced drive outputs
- · Power-off disable outputs permits live insertion
- Edge-rate control circuitry for reduced noise
- FCT-C speed at 4.1 ns
- Latch-up performance exceeds JEDEC standard no. 17
- Typical output skew < 250 ps
- Industrial temperature range of -40°C to +85°C
- TSSOP (19.6-mil pitch) or SSOP (25-mil pitch)
- Typical V_{olp} (ground bounce) performance exceeds Mil Std 883D
- V_{CC} = 2.7V to 3.6V
- ESD (HBM) > 2000V

Functional Description

The CY74FCT163827 is a 20-bit buffer/line driver that provides high-performance bus interface buffering for wide data/address paths or buses carrying parity. It can be used as a single 20-bit buffer or two 10-bit buffers. Each 10-bit buffer has a pair of NANDed $\overline{\text{OE}}$ for increased flexibility.

The CY74FCT163827 has 24-mA balanced output drivers with current limiting resistors in the outputs. This reduces the need for external terminating resistors and provides for minimal undershoot and reduced ground bounce. The inputs and outputs were designed to be capable of being driven by 5.0V buses, allowing its use in mixed voltage systems as a translator. The outputs are also designed with a power-off disable feature enabling its use in applications requiring live insertion.





Pin Description

Name	Description
OE	Output Enable Inputs (Active LOW)
Α	Data Inputs
Υ	Three-State Outputs

Function Table^[1]

	Inputs		Outputs
OE ₁	ŌE ₂	Α	Y
L	L	L	L
L	L	Н	Н
Н	Х	Х	Z
Х	Н	Х	Z

Maximum Ratings^[2, 3]

(Above which the useful life may guidelines, not tested.)	be impaired. For user
Storage Temperature	–55°C to +125°C
Ambient Temperature with Power Applied	–55°C to +125°C
Supply Voltage Range	0.5V to +4.6V
DC Input Voltage	0.5V to +7.0V
DC Output Voltage	0.5V to +7.0V
DC Output Current (Maximum Sink Current/Pin)	60 to +120 mA
Power Dissipation	1.0W

Operating Range

Range	Ambient Temperature	V _{CC}
Commercial	–40°C to +85°C	2.7V to 3.6V

Electrical Characteristics Over the Operating Range V_{CC}=2.7V to 3.6V

Parameter	Description	Test Cond	ditions	Min.	Typ. ^[4]	Max.	Unit
V _{IH}	Input HIGH Voltage	All Inputs		2.0		5.5	V
V _{IL}	Input LOW Voltage					0.8	V
V _H	Input Hysteresis ^[5]						mV
V _{IK}	Input Clamp Diode Voltage	V _{CC} =Min., I _{IN} =–18	3 mA		-0.7	- 1.2	V
I _{IH}	Input HIGH Current	V _{CC} =Max., V _I =5.5				±1	μΑ
I _{IL}	Input LOW Current	V _{CC} =Max., V _I =GN			±1	μΑ	
I _{OZH}	High Impedance Output Current (Three-State Output pins)	V _{CC} =Max., V _{OUT} =			±1	μΑ	
I _{OZL}	High Impedance Output Current (Three-State Output pins)	V _{CC} =Max., V _{OUT} =GND				±1	μΑ
I _{OS}	Short Circuit Current ^[6]	V _{CC} =Max., V _{OUT} =	GND	-60	-135	-240	mA
I _{OFF}	Power-Off Disable	V _{CC} =0V, V _{OUT} ≤4.	5V			±100	μΑ
I _{CC}	Quiescent Power Supply Current	V _{IN} ≤0.2V, V _{IN} ≥V _{CC} −0.2V	V _{CC} =Max.		0.1	10	μΑ
Δl _{CC}	Quiescent Power Supply Current (TTL inputs HIGH)	V _{IN} =V _{CC} -0.6V ^[7]	V _{CC} =Max.		2.0	30	μΑ

- H = HIGH Voltage Level, L = LOW Voltage Level, X = Don't Care, Z = HIGH Impedance.

 Operation beyond the limits set forth may impair the useful life of the device. Unless otherwise noted, these limits are over the operating free-air temperature

- Operation beyond the limits set forth may impair the useful life of the device. Others otherwise notes, and an appropriate logic voltage level, preferably either V_{CC} or ground.
 Unused inputs must always be connected to an appropriate logic voltage level, preferably either V_{CC} or ground.
 Typical values are at V_{CC}=3.3V, T_A = +25°C ambient.
 This parameter is specified but not tested.
 Not more than one output should be shorted at a time. Duration of short should not exceed one second. The use of high-speed test apparatus and/or sample and hold techniques are preferable in order to minimize internal chip heating and more accurately reflect operational values. Otherwise prolonged shorting of a high output may raise the chip temperature well above normal and thereby cause invalid readings in other parametric tests. In any sequence of parameter tests, I_{OS} tests should be performed last.
 Per TTL driven input; all other inputs at V_{CC} or GND.



Electrical Characteristics For Balanced Drive Devices Over the Operating Range V_{CC} =2.7V to 3.6V

Parameter	Description	Test Conditions	Min.	Typ. ^[4]	Max.	Unit
I _{ODL}	Output LOW Dynamic Current ^[6]	V_{CC} =3.3V, V_{IN} = V_{IH} or V_{IL} , V_{OUT} =1.5V	45		180	mA
I _{ODH}	Output HIGH Dynamic Current ^[6]	V_{CC} =3.3V, V_{IN} = V_{IH} or V_{IL} , V_{OUT} =1.5V	-45		-180	mA
V _{OH}	Output HIGH Voltage	V _{CC} =Min., I _{OH} = -0.1 mA	V _{CC} -0.2			V
		V _{CC} =Min., I _{OH} = -8 mA	2.4 ^[8]	3.0		V
		V_{CC} =3.0V, I_{OH} = -24 mA	2.0	3.0		V
V _{OL}	Output LOW Voltage	V _{CC} =Min., I _{OL} = 0.1mA			0.2	V
		V _{CC} =Min., I _{OL} = 24 mA		0.3	0.55	

$\textbf{Capacitance}^{[5]}(T_{A} = +25^{\circ}C, \text{ f} = 1.0 \text{ MHz})$

Parameter	Description	Test Conditions	Typ. ^[4]	Max.	Unit
C _{IN}	Input Capacitance	$V_{IN} = 0V$	4.5	6.0	pF
C _{OUT}	Output Capacitance	V _{OUT} = 0V	5.5	8.0	pF

Note:

Power Supply Characteristics

Parameter	Description	Test Condition	ons	Typ. ^[4]	Max.	Unit
I _{CCD}	Dynamic Power Supply Current ^[9]	V _{CC} =Max., One Input Toggling, 50% Duty Cycle, Outputs Open, OE=GND	V _{IN} =V _{CC} or V _{IN} =GND	50	75	μA/MHz
I _C	Total Power Supply Current ^[10]	Duty Cycle, Outputs Open, One Bit Toggling, OE=GND	V _{IN} =V _{CC} or V _{IN} =GND	0.5	0.8	mA
			V _{IN} =V _{CC} -0.6V or V _{IN} =GND	0.5	0.8	mA
		V _{CC} =Max., f ₁ =2.5 MHz, 50% Duty Cycle, Outputs Open, Six-	V _{IN} =V _{CC} or V _{IN} =GND	2.0	3.0 ^[11]	mA
		teen Bits Toggling, OE=GND	V _{IN} =V _{CC} -0.6V or V _{IN} =GND	2.0	3.3 ^[11]	mA

^{8.} $V_{OH}=V_{CC}-0.6V$ at rated current.



Switching Characteristics Over the Operating Range V_{CC} =3.0V to 3.6V^[12,13]

		CY74FCT163827A		CY74FCT163827C			
Parameter	Description	Min.	Max.	Min.	Max.	Unit	Fig. No. ^[14]
t _{PLH} t _{PHL}	Propagation Delay Data to Output	1.5	4.8	1.5	4.1	ns	1, 3
t _{PZH}	Output Enable Time	1.5	6.2	1.5	5.8	ns	1, 7, 8
t _{PHZ} t _{PLZ}	Output Disable Time	1.5	5.6	1.5	5.2	ns	1, 7, 8
t _{SK(O)}	Output Skew ^[15]		0.5		0.5	ns	_

Notes:

This parameter is not directly testable, but is derived for use in Total Power Supply calculations. $\begin{matrix} I_C &=& I_{QUIESCENT} + I_{INPUTS} + I_{DYNAMIC} \\ I_C &=& I_{CC} + \Delta I_{CC} D_H N_T + I_{CCD} (f_0/2 + f_1 N_1) \\ I_{CC} &=& Quiescent Current with CMOS input levels \\ \Delta I_{CC} &=& Power Supply Current for a TTL HIGH input (V_{IN}=3.4V) \\ D_{DUSCENT} &=& Duty Cycle for TTL inputs | IICH | ICH |$

D_H = Duty Cycle for TTL inputs HIGH
N_T = Number of TTL inputs at D_H
I_{CCD} = Dynamic Current caused by an input transition pair (HLH or LHL)

Clock frequency for registered devices, otherwise zero
 Input signal frequency
 Number of inputs changing at f₁

N₁ = Number of inputs changing at r₁
 All currents are in milliamps and all frequencies are in megahertz.
 1. Values for these conditions are examples of the I_{CC} formula. These limits are specified but not tested.
 12. Minimum limits are guaranteed but not tested on Propagation Delays.
 13. For V_{CC} =2.7, propagation delay, output enable and output disable times should be degraded by 20%.
 14. See "Parameter Measurement Information" in the General Information section.
 15. Skew between any two outputs of the same package switching in the same direction. This parameter is ensured by design.

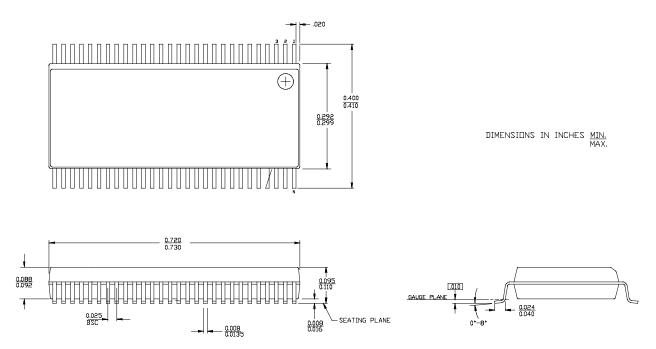
Ordering Information CY74FCT163827

Speed (ns)	Ordering Code	Package Name	Package Type	Operating Range
4.1	CY74FCT163827CPACT	Z56	56-Lead (240-Mil) TSSOP	Commercial
	CY74FCT163827CPVC/PVCT	O56	56-Lead (300-Mil) SSOP	
4.8	CY74FCT163827APVC/PVCT	O56	56-Lead (300-Mil) SSOP	Commercial

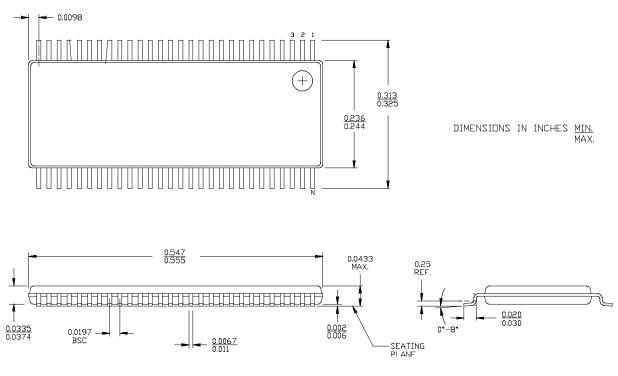


Package Diagrams

56-Lead Shrunk Small Outline Package O56



56-Lead Thin Shrunk Small Outline Package Z56







i.com 30-Mar-2005

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
CY74FCT163827APVC	OBSOLETE	SSOP	DL	56	TBD	Call TI	Call TI
CY74FCT163827APVCT	OBSOLETE	SSOP	DL	56	TBD	Call TI	Call TI
CY74FCT163827CPAC	OBSOLETE	TSSOP	DGG	56	TBD	Call TI	Call TI
CY74FCT163827CPACT	OBSOLETE	TSSOP	DGG	56	TBD	Call TI	Call TI
CY74FCT163827CPVC	OBSOLETE	SSOP	DL	56	TBD	Call TI	Call TI
CY74FCT163827CPVCT	OBSOLETE	SSOP	DL	56	TBD	Call TI	Call TI

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

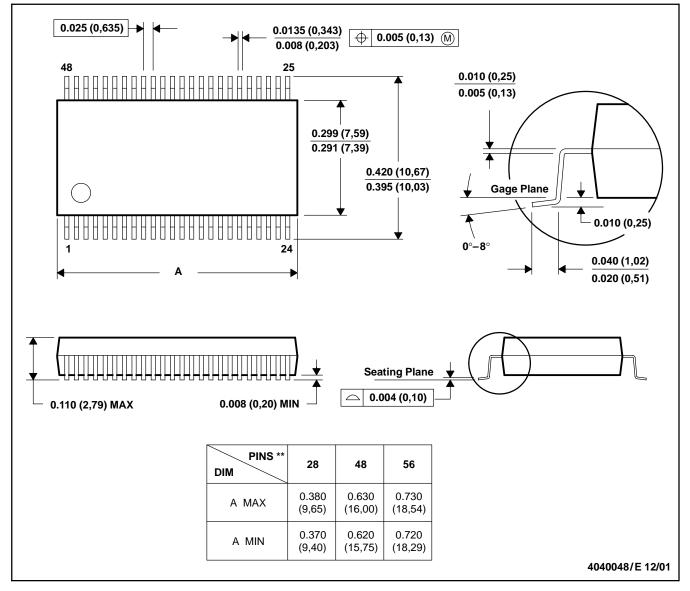
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DL (R-PDSO-G**)

48 PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

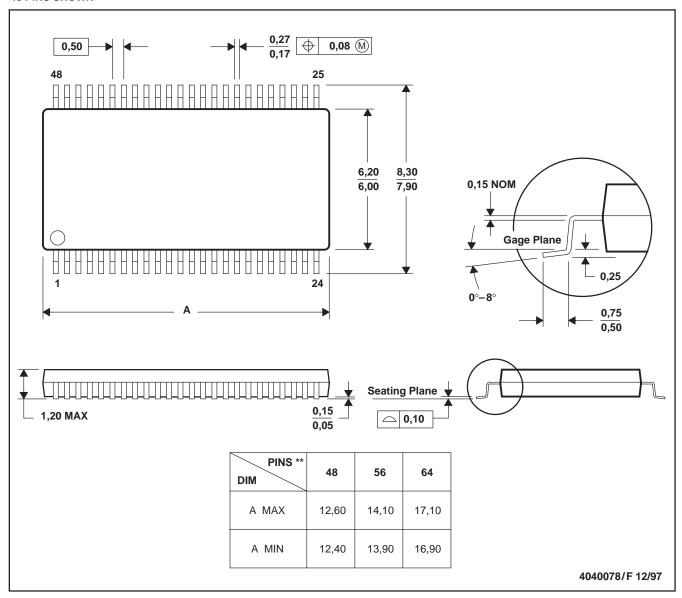
C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MO-118

DGG (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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